

DS92LV1023E

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# DS92LV1023E 30-66 MHz 10 Bit Bus LVDS Serializer

Check for Samples: DS92LV1023E

## FEATURES

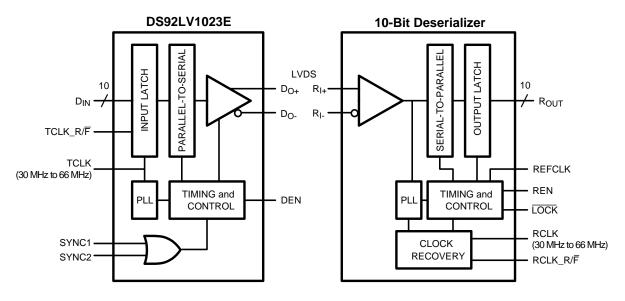
- 30–66 MHz Single 10:1 Serializer with 300–660 Mb/s Throughput
- Robust Bus LVDS Serial Data Transmission with Embedded Clock for Exceptional Noise Immunity and Low EMI
- >10 kV HBM ESD Protection on Bus LVDS Output Pins
- Transition Every Data Transfer Cycle Ensured
- Low Power Consumption < 250 mW (typ) at 66 MHz
- Single Differential Pair Eliminates Multichannel
  Skew
- Flow-Through Pinout for Easy PCB Layout
- Programmable Edge Trigger on Clock
- High Impedance on Driver Outputs When Power is Off
- Bus LVDS Serial Output Rated for 27Ω Load
- Small 28-Lead SSOP Package

## DESCRIPTION

The DS92LV1023E is a 300 to 660 Mb/s serializer for high-speed unidirectional serial data transmission over FR-4 printed circuit board backplanes and balanced copper cables. It transforms a 10-bit wide parallel LVCMOS/LVTTL data bus into a single high speed Bus LVDS serial data stream with embedded clock. This single serial data stream simplifies PCB design and reduces PCB cost by narrowing data paths that in turn reduce PCB size and number of layers. The single serial data stream also reduces cable size, the number of connectors, and eliminates clock-to-data and data-to-data skew.

The DS92LV1023E works well with any TI Semiconductor's Bus LVDS 10–bit deserializer within its specified frequency operating range. It features exceptional ESD protection, pin selectable edge trigger on clock, and high impedance outputs in power down mode.

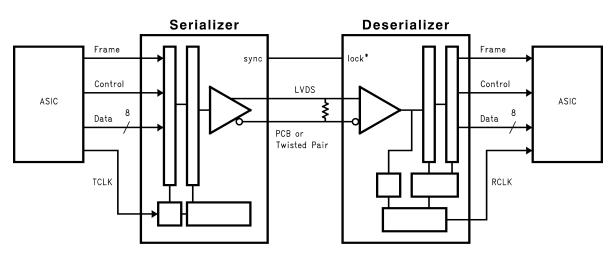
The DS92LV1023E was designed with the flowthrough pinout and is available in a space saving 28–lead SSOP package.



Block Diagrams

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## **Functional Description**

The DS92LV1023E is a 10-bit Serializer device which together with a compatible deserializer (i.e. DS92LV1224) forms a chipset designed to transmit data over FR-4 printed circuit board backplanes and balanced copper cables at clock speeds from 30 to 66 MHz.

The chipset has three active states of operation: Initialization, Data Transfer, and Resynchronization; and two passive states: Powerdown and TRI-STATE.

The following sections describe each operation and passive state.

## Initialization

Initialization of both devices must occur before data transmission begins. Initialization refers to synchronization of the Serializer and Deserializer PLL's to local clocks, which may be the same or separate. Afterwards, synchronization of the Deserializer to Serializer occurs.

Step 1: When you apply V<sub>CC</sub> to both Serializer and/or Deserializer, the respective outputs enter TRI-STATE, and on-chip power-on circuitry disables internal circuitry. When V<sub>CC</sub> reaches V<sub>CC</sub>OK (2.5V) the PLL in each device begins locking to a local clock. For the Serializer, the local clock is the transmit clock (TCLK) provided by the source ASIC or other device. For the Deserializer, you must apply a local clock to the REFCLK pin.

The Serializer outputs remain in TRI-STATE while the PLL locks to the TCLK. After locking to TCLK, the Serializer is now ready to send data or SYNC patterns, depending on the levels of the SYNC1 and SYNC2 inputs or a data stream. The SYNC pattern sent by the Serializer consists of six ones and six zeros switching at the input clock rate.

Note that the Deserializer LOCK output will remain high while its PLL locks to the incoming data or to SYNC patterns on the input.

Step 2: The Deserializer PLL must synchronize to the Serializer to complete initialization. The Deserializer will lock to non-repetitive data patterns. However, the transmission of SYNC patterns enables the Deserializer to lock to the Serializer signal within a specified time. See Figure 7.

The user's application determines control of the SYNC1 and SYNC 2 pins. One recommendation is a direct feedback loop from the LOCK pin. Under all circumstances, the Serializer stops sending SYNC patterns after both SYNC inputs return low.

When the Deserializer detects edge transitions at the Bus LVDS input, it <u>will attempt to lock to the embedded</u> clock information. When the Deserializer locks to the Bus LVDS clock, the LOCK output will go low. When LOCK is low, the Deserializer outputs represent incoming Bus LVDS data.



### **Data Transfer**

After initialization, the Serializer will accept data from inputs DIN0–DIN9. The Serializer uses the TCLK input to latch incoming Data. The TCLK\_R/F pin selects which edge the Serializer uses to strobe incoming data. TCLK\_R/F high selects the rising edge for clocking data and low selects the falling edge. If either of the SYNC inputs is high for 5\*TCLK cycles, the data at DIN0-DIN9 is ignored regardless of clock edge.

After determining which clock edge to use, a start and stop bit, appended internally, frame the data bits in the register. The start bit is always high and the stop bit is always low. The start and stop bits function as the embedded clock bits in the serial stream.

The Serializer transmits serialized data and clock bits (10+2 bits) from the serial data output (DO±) at 12 times the TCLK frequency. For example, if TCLK is 66 MHz, the serial rate is  $66 \times 12 = 792$  Mega-bits-per-second. Since only 10 bits are from input data, the serial "payload" rate is 10 times the TCLK frequency. For instance, if TCLK = 66 MHz, the payload data rate is  $66 \times 10 = 660$  Mbps. The data source provides TCLK and must be in the range of 30 MHz to 66 MHz nominal.

The Serializer outputs  $(DO\pm)$  can drive a point-to-point connection or in <u>limited</u> multi-point or multi-drop backplanes. The outputs transmit data when the enable pin (DEN) is high, PWRDN = high, and SYNC1 and SYNC2 are low. When DEN is driven low, the Serializer output pins will enter TRI-STATE.

When the Deserializer synchronizes to the Serializer, the LOCK pin is low. The Deserializer locks to the embedded clock and uses it to recover the serialized data. ROUT data is valid when LOCK is low. Otherwise ROUT0–ROUT9 is invalid.

The ROUT0-ROUT9 pins use the RCLK pin as the reference to data. The polarity of the RCLK edge is controlled by the RCLK\_R/F input.

ROUT(0-9), LOCK and RCLK outputs will drive a maximum of three CMOS input gates (15 pF load) with a 66 MHz clock.

### Resynchronization

When the Deserializer PLL locks to the embedded clock edge, the Deserializer LOCK pin asserts a low. If the Deserializer loses lock, the LOCK pin output will go high and the outputs (including RCLK) will enter TRI-STATE.

The user's system monitors the LOCK pin to detect a loss of synchronization. Upon detection, the system can arrange to pulse the Serializer SYNC1 or SYNC2 pin to resynchronize. Multiple resynchronization approaches are possible. One recommendation is to provide a feedback loop using the LOCK pin itself to control the sync request of the Serializer (SYNC1 or SYNC2). Dual SYNC pins are provided for multiple control in a multi-drop application. Sending sync patterns for resynchronization is desirable when lock times within a specific time are critical. However, the Deserializer can lock to random data, which is discussed in the next section.

### Random Lock Initialization and Resynchronization

The initialization and resynchronization methods described in their respective sections are the fastest ways to establish the link between the Serializer and Deserializer. However, the DS92LV1224 can attain lock to a data stream without requiring the Serializer to send special SYNC patterns. This allows the DS92LV1224 to operate in "open-loop" applications. Equally important is the Deserializer's ability to support hot insertion into a running backplane. In the open loop or hot insertion case, we assume the data stream is essentially random. Therefore, because lock time varies due to data stream characteristics, we cannot possibly predict exact lock time. The primary constraint on the "random" lock time is the initial phase relation between the incoming data and the REFCLK when the Deserializer powers up. As described in the next paragraph, the data contained in the data stream can also affect lock time.



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If a specific pattern is repetitive, the Deserializer could enter "false lock" - falsely recognizing the data pattern as the clocking bits. We refer to such a pattern as a repetitive multi-transition, RMT. This occurs when more than one Low-High transition takes place in a clock cycle over multiple cycles. This occurs when any bit, except DIN 9, is held at a low state and the adjacent bit is held high, creating a 0-1 transition. In the worst case, the Deserializer could become locked to the data pattern rather than the clock. Circuitry within the DS92LV1224 can detect that the possibility of "false lock" exists. The circuitry accomplishes this <u>by detecting</u> more than one potential position for clocking bits. Upon detection, the circuitry will prevent the LOCK output from becoming active until the potential "false lock" pattern changes. The false lock detect circuitry expects the data will eventually change, causing the Deserializer to lose lock to the data pattern and then continue searching for clock bits in the serial data stream. Graphical representations of RMT are shown in Figure 1. Please note that RMT only applies to bits DIN0-DIN8.

### Powerdown

When no data transfer occurs, you can use the Powerdown state. The Serializer and Deserializer use the Powerdown state, a low power sleep mode, to reduce power consumption. The Deserializer enters Powerdown when you drive PWRDN and REN low. The Serializer enters Powerdown when you drive PWRDN low. In Powerdown, the PLL stops and the outputs enter TRI-STATE, which disables load current and reduces supply current to the milliampere range. To exit Powerdown, you must drive the PWRDN pin high.

Before valid data exchanges between the Serializer and Deserializer, you must reinitialize and resynchronize the devices to each other. Initialization of the Serializer takes 510 TCLK cycles. The Deserializer will initialize and assert LOCK high until lock to the Bus LVDS clock occurs.



### **TRI-STATE**

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The Serializer enters TRI-STATE when the DEN pin is driven low. This puts both driver output pins (DO+ and DO-) into TRI-STATE. When you drive DEN high, the Serializer returns to the previous state, as long as all other control pins remain static (SYNC1, SYNC2, PWRDN, TCLK\_R/F).

When you drive the REN pin low, the Deserializer enters TRI-STATE. Consequently, the receiver output pins (ROUT0–ROUT9) and RCLK will enter TRI-STATE. The LOCK output remains active, reflecting the state of the PLL.

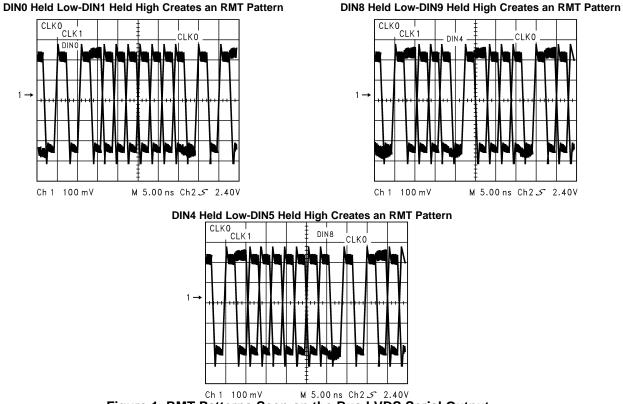


Figure 1. RMT Patterns Seen on the Bus LVDS Serial Output

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## Absolute Maximum Ratings<sup>(1)(2)(3)(4)</sup>

| , according the maximum reading of    |                 |                                  |
|---------------------------------------|-----------------|----------------------------------|
| Supply Voltage (V <sub>CC</sub> )     |                 | -0.3V to +4V                     |
| LVCMOS/LVTTL Input Voltage            |                 | -0.3V to (V <sub>CC</sub> +0.3V) |
| Bus LVDS Driver Output Voltage        | -0.3V to +3.9V  |                                  |
| Bus LVDS Output Short Circuit Durat   | 10ms            |                                  |
| Junction Temperature                  | +150°C          |                                  |
| Storage Temperature                   | −65°C to +150°C |                                  |
| Lead Temperature (Soldering, 4 second | +260°C          |                                  |
| Maximum Package Power Dissipation C   | Capacity        |                                  |
| @ 25°C Package:<br>28L SSOP           | 1.27 W          |                                  |
| Package Derating:                     |                 | 10.3 mW/°C above                 |
| 28L SSOP                              |                 | +25°C                            |
| θ <sub>ja</sub>                       |                 | 97°C/W                           |
| θ <sub>jc</sub>                       |                 | 27°C/W                           |
|                                       | All pins        | >7kV                             |
|                                       | Bus LVDS pins   | >10kV                            |
| ESD RatingHBM (1.5kOhm, 100pF)        | MM              | > 250V                           |

"Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be ensured. They are not meant to imply (1) that the devices should be operated at these limits. The table of "Electrical Characteristics" specifies conditions of device operation.

- If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and (2)specifications
- (3)
- Typical values are given for  $V_{CC} = 3.3V$  and  $T_A = +25^{\circ}C$ . Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground (4) except VOD, ΔVOD, VTH and VTL which are differential voltages.

## Recommended Operating Conditions<sup>(1)(2)</sup>

|  | Min | Nom | Max | Units                |
|--|-----|-----|-----|----------------------|
| Supply Voltage (V <sub>CC</sub> )                | 3.0 | 3.3 | 3.6 | V                    |
| Operating Free Air Temperature (T <sub>A</sub> ) | -40 | +25 | +85 | °C                   |
| Supply Noise Voltage(V <sub>CC</sub> )           |     |     | 1   | 00 mV <sub>P-P</sub> |

Typical values are given for V<sub>CC</sub> = 3.3V and T<sub>A</sub> = +25°C. (1)

Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground (2)except VOD, ΔVOD, VTH and VTL which are differential voltages.



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## Electrical Characteristics<sup>(1)(2)</sup>

Over recommended operating supply and temperature ranges unless otherwise specified.

|                   | Parameter                               | Test Condit   | Test Conditions |      |       | Max  | Units |  |  |
|-------------------|---|---|-----------------|------|-------|------|-------|--|--|
| SERIAL            | IZER LVCMOS/LVTTL DC SPECIFICATION      | (apply to DIN0-9, TCLK, PWRDN, TCLK_R/F, SYNC1, SYNC2, DEN) |                 |      |       |      |       |  |  |
| VIH               | High Level Input Voltage                |   |                 |      |       |      | V     |  |  |
| V <sub>IL</sub>   | Low Level Input Voltage                 |   |                 | GND  |       | 0.8  | V     |  |  |
| V <sub>CL</sub>   | Input Clamp Voltage                     | I <sub>CL</sub> = −18 mA                                    |                 |      | -0.86 | -1.5 | V     |  |  |
| I <sub>IN</sub>   | Input Current                           | V <sub>IN</sub> = 0V or 3.6V                                |                 | -15  | ±1    | +15  | μA    |  |  |
| SERIAL            | IZER Bus LVDS DC SPECIFICATIONS (app    | ly to pins DO+ and DO-)                                     |                 |      |       |      |       |  |  |
| V <sub>OD</sub>   | Output Differential Voltage (DO+)-(DO-) | RL = 27Ω, Figure 11   | 200             | 290  |       | mV   |       |  |  |
| $\Delta V_{OD}$   | Output Differential Voltage Unbalance   |   |                 |      | 35    | mV   |       |  |  |
| V <sub>OS</sub>   | Offset Voltage                          |   | 1.05            | 1.1  | 1.3   | V    |       |  |  |
| $\Delta V_{OS}$   | Offset Voltage Unbalance                | -   |                 |      | 4.8   | 35   | mV    |  |  |
| I <sub>OS</sub>   | Output Short Circuit Current            | $D0 = 0V, DIN = High, \overline{PWR}$<br>2.4V               | DN and DEN =    |      | -56   | -90  | mA    |  |  |
| I <sub>OZ</sub>   | TRI-STATE Output Current                | $\overline{PWRDN}$ or DEN = 0.8V, D                         | O = 0V or VCC   | -30  | ±1    | +30  | μA    |  |  |
| I <sub>OX</sub>   | Power-Off Output Current                | VCC = 0V, DO=0V or 3.6V                                     |                 | -100 | ±1    | +100 | μA    |  |  |
| Co                | Single-ended Output Capacitance         | Any BLVDS Output Pin to                                     |                 |      | 7.5   | pF   |       |  |  |
| SERIAL            | IZER SUPPLY CURRENT (apply to pins DV   | CC and AVCC)  |                 |      | r     |      |       |  |  |
| I <sub>CCD</sub>  | Serializer Supply Current               | RL = 27Ω  | f = 30 MHz      |      | 42    | 60   | mA    |  |  |
|                   | Worst Case                              | Figure 2  | f = 66 MHz      |      | 75    | 90   | mA    |  |  |
| I <sub>CCXD</sub> | Serializer Supply Current Powerdown     | PWRDN = 0.8V  |                 |      | 47    | 500  | μA    |  |  |

Typical values are given for V<sub>CC</sub> = 3.3V and T<sub>A</sub> = +25°C.
 Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground except VOD, ΔVOD, VTH and VTL which are differential voltages.

### Serializer Timing Requirements for TCLK

Over recommended operating supply and temperature ranges unless otherwise specified.

|                   | Parameter                  | Test Conditions | Min   | Тур  | Max   | Units       |
|-------------------|----------------------------|-----------------|-------|------|-------|-------------|
| t <sub>TCP</sub>  | Transmit Clock Period      |                 | 15.15 | Т    | 33.33 | ns          |
| t <sub>TCIH</sub> | Transmit Clock High Time   |                 | 0.4T  | 0.5T | 0.6T  | ns          |
| t <sub>TCIL</sub> | Transmit Clock Low Time    |                 | 0.4T  | 0.5T | 0.6T  | ns          |
| t <sub>CLKT</sub> | TCLK Input Transition Time |                 |       | 3    | 6     | ns          |
| t <sub>JIT</sub>  | TCLK Input Jitter          | See Figure 10   |       |      | 150   | ps<br>(RMS) |



## Serializer Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified.

|                   | Parameter                               | Test Cond                               | Test Conditions |                        |                        | Max                    | Units       |
|-------------------|---|---|-----------------|------------------------|------------------------|------------------------|-------------|
| t <sub>LLHT</sub> | Bus LVDS Low-to-High<br>Transition Time | $R_L = 27\Omega$<br>$C_L=10pF$ to GND   |                 | 0.2                    | 0.4                    | ns                     |             |
| t <sub>LHLT</sub> | Bus LVDS High-to-Low Transition Time    | Figure 3                                |                 |                        | 0.25                   | 0.4                    | ns          |
| t <sub>DIS</sub>  | DIN (0-9) Setup to TCLK                 | $R_L = 27\Omega$ ,                      |                 | 0                      |                        |                        | ns          |
| t <sub>DIH</sub>  | DIN (0-9) Hold from TCLK                | C <sub>L</sub> =10pF to GND<br>Figure 5 |                 | 4.0                    |                        |                        | ns          |
| t <sub>HZD</sub>  | DO ± HIGH to<br>TRI-STATE Delay         | $R_L = 27\Omega,$<br>$C_L=10pF$ to GND  |                 |                        | 3                      | 10                     | ns          |
| t <sub>LZD</sub>  | DO ± LOW to TRI-STATE Delay             | Figure 6                                |                 |                        | 3                      | 10                     | ns          |
| t <sub>ZHD</sub>  | DO ± TRI-STATE to HIGH Delay            |   |                 |                        | 5                      | 10                     | ns          |
| t <sub>ZLD</sub>  | DO ± TRI-STATE to LOW Delay             |   |                 |                        | 6.5                    | 10                     | ns          |
| t <sub>SPW</sub>  | SYNC Pulse Width                        | $R_L = 27\Omega$                        |                 | 5*t <sub>TCP</sub>     |                        |                        | ns          |
| t <sub>PLD</sub>  | Serializer PLL Lock Time                | Figure 8                                |                 | 510*t <sub>TCP</sub>   |                        | 513*t <sub>TCP</sub>   | ns          |
| t <sub>SD</sub>   | Serializer Delay                        | $R_L = 27\Omega$ , Figure 9             |                 | t <sub>TCP</sub> + 1.0 | t <sub>TCP</sub> + 2.0 | t <sub>TCP</sub> + 3.0 | ns          |
| t <sub>DJIT</sub> | Deterministic Jitter                    | $R_L = 27\Omega$ ,                      | 30 MHz          | -350                   | -45                    | 190                    | ps          |
|                   |   | $C_{L}^{-}$ =10pF to GND,               | 66 MHz          | -200                   | -70                    | 80                     | ps          |
| t <sub>RJIT</sub> | Random Jitter                           | $R_L = 27\Omega$ ,<br>$C_L=10pF$ to GND |                 |                        | 19                     | 25                     | ps<br>(RMS) |

(1)

t<sub>LLHT</sub> and t<sub>LHLT</sub> specifications are Guranteed By Design (GBD) using statistical analysis. Because the Serializer is in TRI-STATE mode, the Deserializer will lose PLL lock and have to resynchronize before data transfer. (2)

(3) t<sub>DJIT</sub> specifications are Guranteed By Design using statistical analysis.

### **AC Timing Diagrams and Test Circuits**

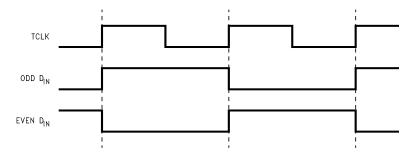


Figure 2. "Worst Case" Serializer ICC Test Pattern

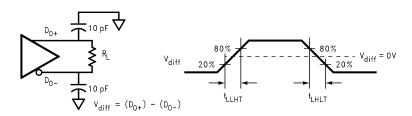
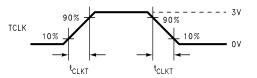
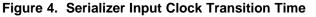


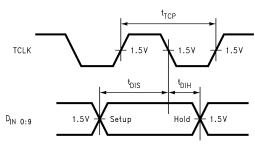
Figure 3. Serializer Bus LVDS Output Load and Transition Times



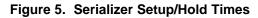


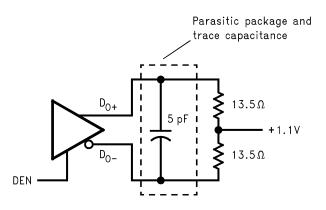
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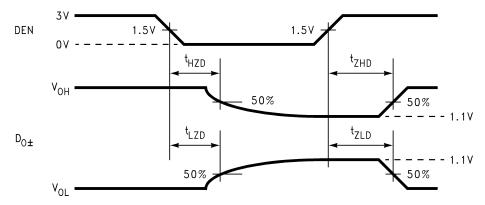




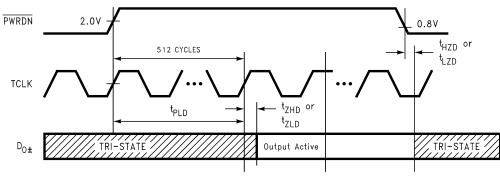














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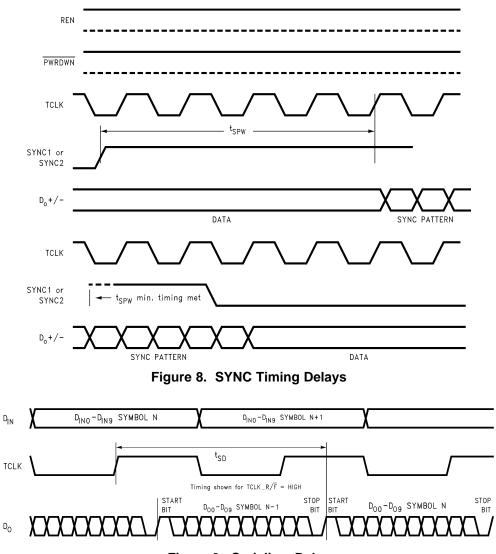
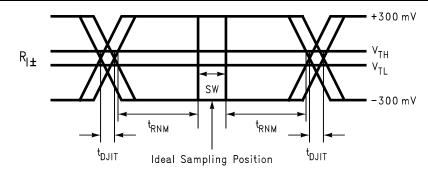


Figure 9. Serializer Delay



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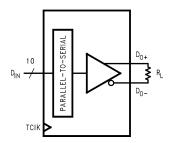
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SW - Setup and Hold Time (Internal Data Sampling Window)

 $t_{\text{DJIT}}$  - Serializer Output Bit Position Jitter that results from Jitter on TCLK  $t_{\text{RNM}}$  = Receiver Noise Margin Time

Figure 10. Receiver Bus LVDS Input Skew Margin



 $V_{OD} = (DO^+)-(DO^-)$ . Differential output signal is shown as (DO+)-(DO-), device in Data Transfer mode.

Figure 11. V<sub>OD</sub> Diagram

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## APPLICATION INFORMATION

### USING THE SERIALIZER AND DESERIALIZER CHIPSET

The Serializer and Deserializer chipset is an easy to use transmitter and receiver pair that sends 10 bits of parallel LVTTL data over a serial Bus LVDS link up to 660 Mbps. An on-board PLL serializes the input data and embeds two clock bits within the data stream. The Deserializer uses a separate reference clock (REFCLK) and an onboard PLL to extract the clock information from the incoming data stream and then deserialize the data. The Deserializer monitors the incoming clock information, determines lock status, and asserts the LOCK output high when loss of lock occurs.

### POWER CONSIDERATIONS

An all CMOS design of the Serializer and Deserializer makes them inherently low power devices. In addition, the constant current source nature of the Bus LVDS outputs minimizes the slope of the speed vs.  $I_{CC}$  curve of conventional CMOS designs.

### TRANSMITTING DATA

Once you power up the Serializer and Deserializer, they must be phase locked to each other to transmit data. Phase locking occurs when the Deserializer locks to incoming data or when the Serializer sends patterns. The Serializer sends SYNC patterns whenever the SYNC1 or SYNC2 inputs are high. The LOCK output of the Deserializer remains high until it has locked to the incoming data stream. Connecting the LOCK output of the Deserializer to one of the SYNC inputs of the Serializer will ensure that enough SYNC patterns are sent to achieve Deserializer lock.

The Deserializer can also lock to incoming data by simply powering up the device and allowing the "random lock" circuitry to find and lock to the data stream.

While the Deserializer  $\overline{LOCK}$  output is low, data at the Deserializer outputs (ROUT0-9) is valid, except for the specific case of loss of lock during transmission which is further discussed in the "Recovering from LOCK Loss" section below.

### HOT INSERTION

All the BLVDS devices are hot pluggable if you follow a few rules. When inserting, ensure the Ground pin(s) makes contact first, then the VCC pin(s), and then the I/O pins. When removing, the I/O pins should be unplugged first, then the VCC, then the Ground. Random lock hot insertion is illustrated in Figure 12.

### PCB CONSIDERATIONS

The Bus LVDS Serializer and Deserializer should be placed as close to the edge connector as possible. In multiple Deserializer applications, the distance from the Deserializer to the slot connector appears as a stub to the Serializer driving the backplane traces. Longer stubs lower the impedance of the bus, increase the load on the Serializer, and lower the threshold margin at the Deserializers. Deserializer devices should be placed much less than one inch from slot connectors. Because transition times are very fast on the Serializer Bus LVDS outputs, reducing stub lengths as much as possible is the best method to ensure signal integrity.

### TRANSMISSION MEDIA

The Serializer and Deserializer can also be used in point-to-point configuration of a backplane, through a PCB trace, or through twisted pair cable. In point-to-point configuration, the transmission media need only be terminated at the receiver end. Please note that in point-to-point configuration, the potential of offsetting the ground levels of the Serializer vs. the Deserializer must be considered. Also, Bus LVDS provides a +/- 1.2V common mode range at the receiver inputs.



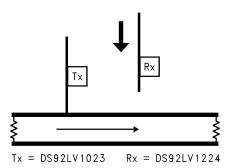


Figure 12. Random Lock Hot Insertion

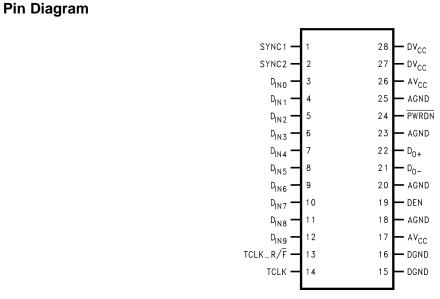


Figure 13. DS92LV1023EMQ - Serializer SSOP Package See Package Number DB0028A

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NSTRUMENTS

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|          | Serializer Pin Description |                |  |  |  |  |  |  |  |  |
|----------|----------------------------|----------------|--|--|--|--|--|--|--|--|
| Pin Name | I/O                        | Pin No.        | Description  |  |  |  |  |  |  |  |
| DIN      | I                          | 3–12           | Data Input. LVTTL levels inputs. Data on these pins are loaded into a 10-bit input register.   |  |  |  |  |  |  |  |
| TCLK_R/F | I                          | 13             | Transmit Clock Rising/Falling strobe select. LVTTL level input. Selects TCLK active edge for strobing of DIN data. High selects rising edge. Low selects falling edge.   |  |  |  |  |  |  |  |
| DO+      | 0                          | 22             | + Serial Data Output. Non-inverting Bus LVDS differential output.  |  |  |  |  |  |  |  |
| DO-      | 0                          | 21             | - Serial Data Output. Inverting Bus LVDS differential output.  |  |  |  |  |  |  |  |
| DEN      | I                          | 19             | Serial Data Output Enable. LVTTL level input. A low, puts the Bus LVDS outputs in TRI-STATE.   |  |  |  |  |  |  |  |
| PWRDN    | I                          | 24             | Powerdown. LVTTL level input. PWRDN driven low shuts down the PLL and TRI-STATEs outputs putting the device into a low power sleep mode.   |  |  |  |  |  |  |  |
| TCLK     | I                          | 14             | Transmit Clock. LVTTL level input. Input for 40 MHz–66 MHz (nominal) system clock.   |  |  |  |  |  |  |  |
| SYNC     | I                          | 1, 2           | Assertion of SYNC (high) for at least 1024 synchronization symbols to be transmitted on the Bus LVDS serial output. Synchronization symbols continue to be sent if SYNC continues asserted. TTL level input. The two SYNC pins are ORed. |  |  |  |  |  |  |  |
| DVCC     | I                          | 27, 28         | Digital Circuit power supply.  |  |  |  |  |  |  |  |
| DGND     | I                          | 15, 16         | Digital Circuit ground.  |  |  |  |  |  |  |  |
| AVCC     | I                          | 17, 26         | Analog power supply (PLL and Analog Circuits).   |  |  |  |  |  |  |  |
| AGND     | I                          | 18, 25, 20, 23 | Analog ground (PLL and Analog Circuits).   |  |  |  |  |  |  |  |



SNLS187B-MARCH 2005-REVISED APRIL 2013

## **REVISION HISTORY**

| Cł | nanges from Revision A (April 2013) to Revision B  | Page | ; |
|----|--|------|---|
| •  | Changed layout of National Data Sheet to TI format | . 14 |   |



13-Sep-2014

## **PACKAGING INFORMATION**

| Orderable Device    | Status | Package Type | Package | Pins | Package | Eco Plan                   | Lead/Ball Finish | MSL Peak Temp       | Op Temp (°C) | Device Marking    | Samples |
|---------------------|--------|--------------|---------|------|---------|----------------------------|------------------|---------------------|--------------|-------------------|---------|
|                     | (1)    |              | Drawing |      | Qty     | (2)                        | (6)              | (3)                 |              | (4/5)             |         |
| DS92LV1023EMQ/NOPB  | ACTIVE | SSOP         | DB      | 28   | 47      | Green (RoHS<br>& no Sb/Br) | CU SN            | Level-3-260C-168 HR | -40 to 85    | DS92LV1023<br>EMQ | Samples |
| DS92LV1023EMQX/NOPB | ACTIVE | SSOP         | DB      | 28   | 2000    | Green (RoHS<br>& no Sb/Br) | CU SN            | Level-3-260C-168 HR | -40 to 85    | DS92LV1023<br>EMQ | Samples |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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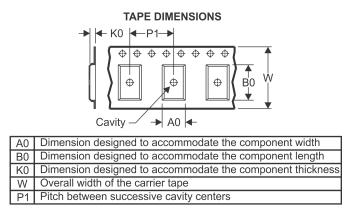
# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | *All | dimensions | are | nominal |
|-----------------------------|------|------------|-----|---------|
|-----------------------------|------|------------|-----|---------|

| Device                  | Package<br>Type | Package<br>Drawing |    |      | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|-------------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| DS92LV1023EMQX/NOP<br>B | SSOP            | DB                 | 28 | 2000 | 330.0                    | 16.4                     | 8.4        | 10.7       | 2.4        | 12.0       | 16.0      | Q1               |

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# PACKAGE MATERIALS INFORMATION

23-Sep-2013



\*All dimensions are nominal

| Device              | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|---------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DS92LV1023EMQX/NOPB | SSOP         | DB              | 28   | 2000 | 367.0       | 367.0      | 38.0        |

# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

## DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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